

# N-Channel 60 V (D-S) MOSFET

# PowerPAK® ChipFET® Single

**Bottom View** 

Top View Marking code: AA

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	60					
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.034					
$R_{DS(on)}$ max. ( $\Omega$ ) at $V_{GS} = 4.5 \text{ V}$	0.041					
Q <sub>g</sub> typ. (nC)	10.5					
I <sub>D</sub> (A) <sup>a</sup>	12					
Configuration	Single					

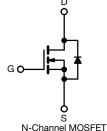
## **FEATURES**

- TrenchFET® power MOSFET
- Thermally enhanced PowerPAK ChipFET package
  - Small footprint area
  - Low on-resistance
  - Thin 0.8 mm profile
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



## **APPLICATIONS**

- · Load switch for portable applications
- DC/DC switch for low synchronous rectification
- Intermediate switch driver for DC/DC G applications



ORDERING INFORMATION	
Package	PowerPAK ChipFET
Lead (Pb)-free and halogen-free	Si5476DU-T1-GE3

<b>ABSOLUTE MAXIMUM RATING</b>	<b>S</b> (T <sub>A</sub> = 25 °C, u	ınless otherw	rise noted)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		$V_{DS}$	60	V	
Gate-source voltage		$V_{GS}$	± 20	v	
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
	T <sub>C</sub> = 70 °C	T . T	12 <sup>a</sup>		
	T <sub>A</sub> = 25 °C	I <sub>D</sub>	7 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	Ī	5.6 b, c		
Pulsed drain current		I <sub>DM</sub>	25	A	
Continuous durin dinda aument	T <sub>C</sub> = 25 °C		12 <sup>a</sup>		
Continuous source-drain diode current	T <sub>A</sub> = 25 °C	l <sub>s</sub>	2.6 b, c		
Avalanche current	1 0111	I <sub>AS</sub>	15		
Single pulse avalanche energy L = 0.1 mH		E <sub>AS</sub>	11.2	mJ	
	T <sub>C</sub> = 25 °C		31		
Marchael and a service of the service of	T <sub>C</sub> = 70 °C	1 _ [	20	147	
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.1 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C	1	2 b, c		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		
Soldering recommendations (peak temperature) d, e		Ŭ	260	°C	

THERMAL RESISTANCE RATING	àS				
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient b, f	t ≤ 5 s	R <sub>thJA</sub>	34	40	°C/W
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	3	4	C/VV

## **Notes**

- Package limited
- Surface mounted on 1" x 1" FR4 board
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components Maximum under steady state conditions is  $90~^{\circ}\text{C/W}$



Vishay Siliconix

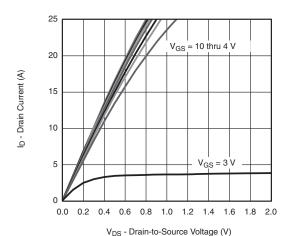
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			•		•		
Drain-source breakdown voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	60	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	55	-		
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-6.3	-	mV/°C	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1	-	3	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zoro goto voltago droin ourrent		V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V	-	-	1	,	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C	-	-	10	μA	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	25	-	-	Α	
Drain actives on state resistance 3	В	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.6 A	-	0.028	0.034	Ω	
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 4.2 \text{ A}$	-	0.033	0.041		
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 4.6 \text{ A}$	-	20	-	S	
Dynamic <sup>b</sup>							
Input capacitance	C <sub>iss</sub>		-	1100	-	pF	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	90	-		
Reverse transfer capacitance	C <sub>rss</sub>		-	55	-	1	
Tabalandanahan	0	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 4.6 \text{ A}$	-	21	32		
Total gate charge	Q <sub>g</sub>		-	10.5	16	1	
Gate-source charge	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.6 \text{ A}$	-	3.5	-	nC	
Gate-drain charge	Q <sub>gd</sub>		-	4.2	-		
Gate resistance	$R_g$	f = 1 MHz	-	3.3	-	Ω	
Turn-on delay time	t <sub>d(on)</sub>		-	20	30		
Rise time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 5.4 \Omega, I_D \cong 5.6 \text{ A},$	-	150	225	7	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$	-	20	30		
Fall time	t <sub>f</sub>		-	60	90	1	
Turn-on delay time	t <sub>d(on)</sub>		-	10	15	ns	
Rise time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, R_L = 5.4 \Omega, I_D \cong 5.6 \text{ A},$	-	15	25		
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	22	40		
Fall time	t <sub>f</sub>		-	10	15		
<b>Drain-Source Body Diode Characterist</b>	ics						
Continuous source-drain diode current	Is	T <sub>C</sub> = 25 °C	-	-	12	^	
Pulse diode forward current	I <sub>SM</sub>		-	-	25	Α	
Body diode voltage	V <sub>SD</sub>	$I_S = 5.5 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.85	1.2	V	
Body diode reverse recovery time	t <sub>rr</sub>		-	25	50	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>	$I_F = 5.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	25	50	nC	
Reverse recovery fall time	t <sub>a</sub>	T <sub>J</sub> = 25 °C	-	19	-		
Reverse recovery rise time	t <sub>b</sub>		_	6	_	ns	

## Notes

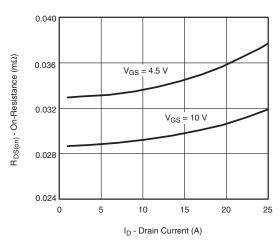
- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

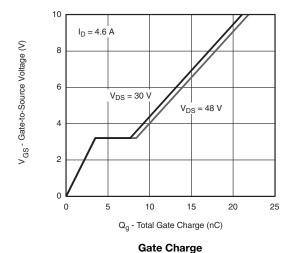




**Output Characteristics** 



On-Resistance vs. Drain Current and Gate Voltage



T<sub>C</sub> = -55 °C

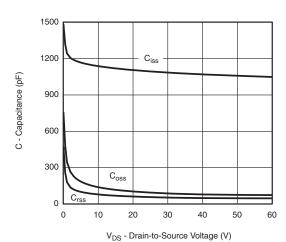
T<sub>C</sub> = -55 °C

T<sub>C</sub> = 125 °C

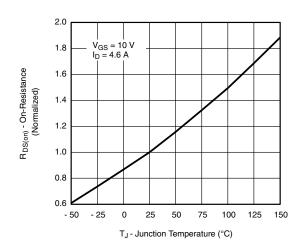
T<sub>C</sub> = 125 °C

V<sub>GS</sub> - Gate-to-Source Voltage (V)

Transfer Characteristics

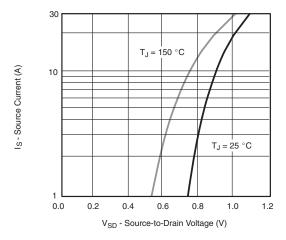


Capacitance

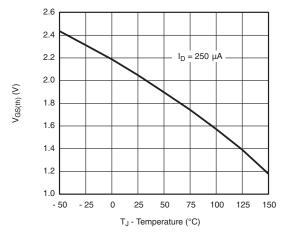


On-Resistance vs. Junction Temperature

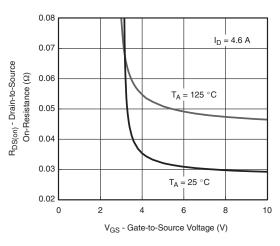




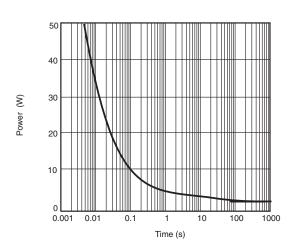
## Source-Drain Diode Forward Voltage



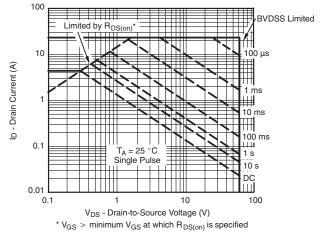
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

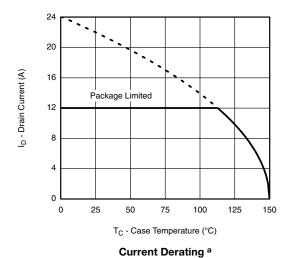


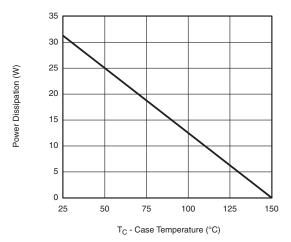
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient





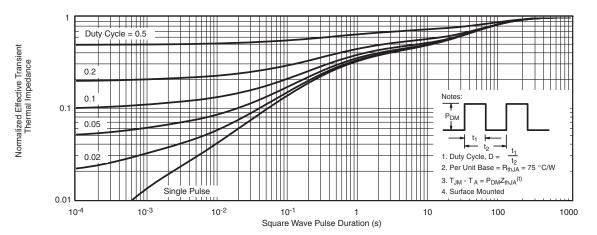


Power Derating

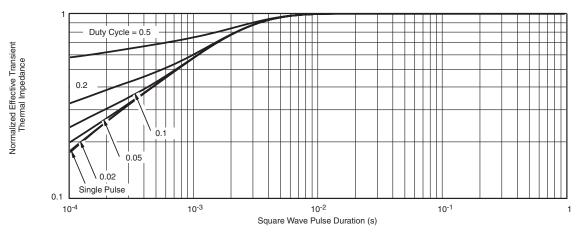
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





## Normalized Thermal Transient Impedance, Junction-to-Ambient

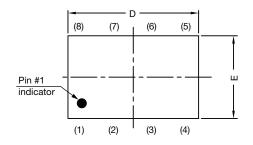


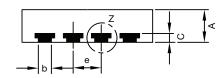
Normalized Thermal Transient Impedance, Junction-to-Case

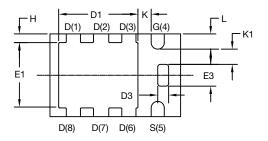
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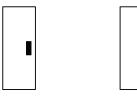
# PowerPAK® ChipFET® Case Outline







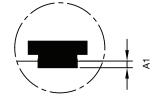
Backside view of single pad



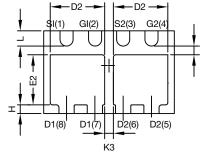
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM	MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е		0.65 BSC		0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	ı	
K1	0.30	-	-	0.012	-	ı	
K2	0.20	-	-	0.008	-	ı	
K3	0.20	-	-	0.008	-	ı	
L	0.30	0.35	0.40	0.012	0.014	0.016	

## C14-0630-Rev. E, 21-Jul-14

## Note

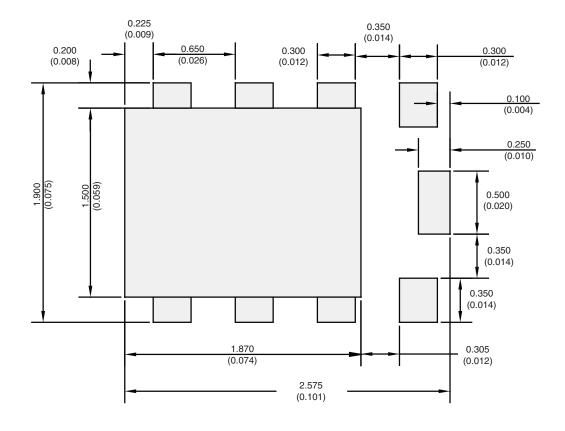
DWG: 5940

Revision: 21-Jul-14

• Millimeters will govern



# RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

Return to Index

APPLICATION NOTE



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